

**CRASH RECOVERY SUPPORT FOR VARIABLE
STRENGTH *T*-WAY TEST GENERATION
STRATEGY**

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**CRASH RECOVERY SUPPORT FOR VARIABLE STRENGTH T-
WAY TEST GENERATION STRATEGY**

by

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LIST OF ABBREVIATIONS

Abbreviation	Meaning
ACA	Ant Colony Algorithm
ACID	Atomicity, Consistency, Isolation and Durability
ACS	Ant Colony System
AETG	Automatic Efficient Test Generator
AI	Artificial Intelligence
AOF	Append-Only File
API	Application Programming Interface
ASIC	Application-Specific Integrated Circuit (ASIC)
AUT	Application Under Test
CA / CAs	Covering Array / Covering Arrays
CPU	Central Processing Unit
DBMS	Database Management Systems
DOE	Design of Experiments
FPGA	Field Programmable Gate Array
GA	Genetic Algorithm
GUI	Graphical User Interface
HDL	Hardware Description Language
IDE	Integrated Desktop Environment
IPO	Input Parameter Order
IPOG	Input Parameter Order Generalized
ISTQB	International Software Testing Qualifications Board
ITCH	IBM's Intelligent Test Case Handler
JDK	Java Development Kit

Abbreviation	Meaning
JVM	Java Virtual Machine
MCA	Mixed Covering Array
NIST	National Institute of Standards and Technology
NP	Nondeterministic Polynomial time
OA / OAs	Orthogonal Array / Orthogonal Arrays
OPAAT	One Parameter At a Time
OTAAT	One Test At a Time
PDCA	Plan-Do-Check-Act
POJO	Plain Old Java Object
PSO	Particle Swarm Optimization
PSTG	Particle Swarm Test Generator
RAM	Random Access Memory
RDBMS	Relational Database Management Systems
SA	Simulated Annealing
SDR	Software-defined Radio
TCAS	Traffic Collision Avoidance System
TCG	Test Case Generator
TSGCR	Test Suite Generator with Crash Recovery support
TVG	Test Vector Generator
VS	Variable Strength
VS-PSTG	Variable-Strength Particle Swarm Test Generator
WHITCH	IBM Intelligent Test Case Handler

**SOKONGAN PEMULIHAN KEGAGALAN UNTUK STRATEGI
PENJANAAN UJIAN HALA-*T* DENGAN KEKUATAN BOLEH UBAH**

ABSTRAK

Selalunya, cabaran terbesar dalam pengujian perisian berkait dengan hakikat bahawa ia tidak boleh dilaksanakan untuk menguji kesemua parameter-parameter input kerana kekangan-kekangan seperti kos, sumber dan masa. Mempertimbangkan faktor-faktor ini, penguji-penguji perisian perlu melakukan pilihan kes-kes ujian yang sesuai supaya sumber-sumber yang sedia ada digunakan dengan cara yang terbaik. Dalam konteks Ujian Kombinasi, penguji-penguji sering mengambil pendekatan strategi penjanaan ujian hala-*t* (di mana *t* menunjukkan kekuatan interaksi). Bukti empirikal dalam literatur menunjukkan bahawa strategi penjanaan ujian hala-*t* telah berjaya mengurangkan kes-kes ujian dengan ketara sambil mengekalkan keupayaan pengesanan kecacatan daripada proses pengujian. Banyak kemajuan yang berguna sudah dicapai berkenaan dengan pembangunan strategi penjanaan ujian hala-*t*. Walau bagaimanapun, beberapa isu masih kekal terutamanya dalam konteks menangani kerumitan dan saiz perisian (iaitu baris-baris kod) yang semakin meningkat mengakibatkan jumlah interaksi antara parameter-parameter input yang tinggi. Pertama, penjanaan ujian boleh mengambil jangka masa yang panjang, sebarang gangguan adalah mahal kerana keseluruhan penjanaan perlu dimulakan semula dari awal. Masa dan usaha-usaha akan menjadi sia-sia. Kedua, strategi sedia ada melakukan pemilihan terlalu awal pada nilai terbaik parameter-parameter input apabila melakukan pensampelan kes-kes ujian. Atas sebab ini, strategi-strategi ini kurang mencukupi dari segi menjana saiz sut ujian yang optimum. Di sini, untuk meningkatkan keupayaan ujian hala-*t*, terdapat juga

keperluan untuk mempertimbangkan strategi kekuatan interaksi boleh ubah. Pendekatan ini sering disukai kerana kompromi dari segi saiz sut ujian kerana strategi ini memberi tumpuan pengujian di mana ia mempunyai nilai yang paling berpotensi yang biasanya dikaitkan dengan analisis risiko dan keutamaan. Untuk menangani isu-isu ini, kajian ini membangunkan strategi penjanaan data ujian dengan kekuatan interaksi boleh ubah, yang dikenali sebagai Penjana Sut Ujian dengan sokongan Pemulihan Kegagalan (TSGCR). Tidak seperti strategi-strategi yang sedia ada, TSGCR menggunakan algoritma tamak bertingkat, yang lewat memilih nilai yang terbaik sehingga ia memenuhi peraturan tertentu. Untuk menyediakan operasi yang boleh diharap, TSGCR juga membenarkan sokongan pemulihan kegagalan bersepadu sebagai sebahagian daripada strategi itu sendiri. Kerana potensi proses penjanaan data ujian yang akan mengambil jangka masa yang panjang (iaitu disebabkan oleh pemilihan parameter-parameter input dan nilai-nilai yang agak besar), TSGCR boleh menghadapi kegagalan transaksi secara paksaan (contohnya seperti kegagalan kuasa atau kesilapan sistem) atau penggantungan pelaksanaan penjanaan secara sukarela (contohnya untuk memberi ruang untuk pengiraan yang lain) membolehkan pemulihan status dan data ke status lepas yang konsisten. Untuk menilai kedayasaan TSGCR, penjanaan ujian diuji dengan parameter-parameter input yang seragam dan campuran dan prestasi (dari segi saiz sut ujian yang dihasilkan) dibandingkan dengan strategi-strategi penjanaan ujian dengan kekuatan hala- t yang berubah-ubah yang sedia ada dengan menggunakan konfigurasi penanda aras piawaian yang terkenal (berdasarkan enam set eksperimen). Hasil kajian penanda arasan menunjukkan bahawa bagi konfigurasi interaksi VS untuk parameter input seragam, TSGCR mendapat tujuh Δ dengan nilai 0, iaitu sama nilai seperti penyelesaian terbaik yang diperolehi dengan strategi-strategi yang lain,

tujuh Δ dengan nilai + ve, yaitu mampu untuk mendapatkan penyelesaian yang terbaik; yaitu empat belas daripada empat puluh empat keputusan eksperimen. Manakala bagi konfigurasi interaksi VS untuk parameter input campuran, TSGCR mendapat dua puluh tujuh Δ dengan nilai 0, lapan Δ dengan nilai + ve; yaitu tiga puluh lima daripada empat puluh satu keputusan eksperimen. Oleh itu, hasil keputusan menunjukkan bahawa TSGCR menghasilkan keputusan yang kompetitif berbanding kebanyakan strategi-strategi yang sedia ada.

CRASH RECOVERY SUPPORT FOR VARIABLE STRENGTH *T*-WAY TEST GENERATION STRATEGY

ABSTRACT

Often, the biggest challenge in software testing relates to the fact that it is not feasible to test for all the input parameters exhaustively owing to constraints in costs, resources and time. Considering these factors, software testers must appropriately sample the test cases in order to best utilize the resources at hand. Within the context of Combinatorial Testing, testers often resort to *t*-way test generation strategy (where *t* indicates the strength of interaction). Empirical evidence in the literature indicated that *t*-way test generation strategy has managed to minimize the test cases significantly whilst maintaining the fault detection capability of the testing process. Much useful progress has been achieved as far as the development of *t*-way test generation strategy is concerned. Nevertheless, some issues remain especially in the context of addressing ever increasing complexity and size of software (i.e. lines of code) resulting into high number of interaction among input parameters. Firstly, the test generation can be painstakingly long, interruption is expensive as the whole generation process needs to be restarted from scratch. Time and efforts will also be wasted. Secondly, existing strategies commit too early on selection of the best value of input parameters when sampling of the test cases. For this reason, these strategies were less sufficient in terms of generating optimal test suite size. Here, to enhance the *t*-way testing capability, there is also a need to consider variable-strength strategy. This approach is often favored because of the compromise in terms of test suite size as the strategy focuses testing where it has the most potential value which usually is associated with a risk analysis and priority. In order to address these issues,

this research develops a variable-strength (VS) interaction t -way test generation strategy, called Test Suite Generator with Crash Recovery support (TSGCR). Unlike existing strategies, TSGCR adopts Multilevel Greedy algorithm, which delays choosing the best value until it satisfies certain rules. To provide a reliable operation, TSGCR also permits crash recovery support integrated as part of the strategy itself. As the test generation can potentially be long lasting processes (i.e. due to large selection of input parameters and values), TSGCR tolerates involuntary transaction failures (e.g. such as power failure or system errors) or voluntary execution suspension (e.g. to give ways for other computations) enabling restoration of state and data to the last consistent state. To evaluate the competitiveness of TSGCR, the test generator is tested with uniform and mixed input parameters and the performance (in terms of the generated test suite size) is compared with existing variable strength t -way test generation strategies using well-known standard benchmark configurations (based on six sets of experiments). Benchmarking results showed that for VS interaction configurations for uniform input parameters, TSGCR is able to get seven Δ with 0 value, i.e. similar value to the best solution obtained by other strategies, seven Δ with +ve values, i.e. able to get the best solution; from fourteen out of forty four experimental results. While for VS interaction configurations for mixed input parameters, TSGCR is able to get twenty seven Δ with 0 value, eight Δ with +ve values; from thirty five out of forty one experimental results. Hence, the results demonstrated that TSGCR produces competitive results as far as the size of the test suite is concerned against most existing strategies.

CHAPTER ONE

INTRODUCTION

Nowadays, people have the tendency to increasingly rely on electronic devices to accommodate their daily life, e.g. automobile, gadget and home appliances. By combining various hardware and software technologies, these devices are providing options to make our life better, i.e. for increasing comfort and efficiency. The technologies inside these devices vary because of the differences in functionalities and innovations.

Typically, manufacturers or solution providers are inclined to replace most hardware implementations with software for cost savings. The reason is quite obvious; unlike hardware, software does not wear out. Moreover, software is malleable and can be easily customized as the need arises, e.g. adding new functionalities (Klaib et al., 2008) such as using a Field Programmable Gate Array (FPGA) or implementing a Software-defined Radio (SDR).

FPGA contains an array of programmable logic blocks and a hierarchy of reconfigurable interconnects that allow the blocks to be wired together using a software programming language called Hardware Description Language (HDL) (Sadrozinski and Wu, 2010). A soft-core processor, which is a HDL model of a specific processor (CPU) can also be customized for a given application and synthesized for FPGA (Tong et al., 2006). At the same time, FPGA can still be configured by a designer even after manufacturing process.

Likewise components in SDR, such as amplifiers, filters and mixers, in the radio communication system which have been commonly implemented in hardware but are instead implemented by means of software on a personal computer or embedded system (Dillinger et al., 2003).

Because of the inclination to choose software-based solutions (e.g. FPGA, SDR, etc.), the complexity and size of software (i.e. lines of code) is ever-increasing while at the same time, testing the software has evolved from a routine quality assurance activity into a sizeable and complex challenge in terms of manageability and effectiveness (Geetha Devasena and Valarmathi, 2012).

Software quality and reliability are the main criteria for success in the software industry. If software is faulty, it is prone to do unexpected behavior resulting into undesirable outcome. Considering that software is becoming more complicated; software testing is becoming immensely important because statistical data shows that it accounts as much as 50 percent of the total software development cost and even more for mission safety critical system (Ammann and Offutt, 2008). Besides, software testing adds considerably to the length of the development cycle.

Lack of testing can lead to disastrous consequence if software is deployed in mission safety critical life threatening application. For instance, in February 25, 1991, the Patriot battery at Dhahran, Saudi Arabia, failed to track and intercept an incoming Iraqi Scud missile that later struck an army barrack, killing 28 Americans. The software problem caused by an inaccurate tracking calculation that became worse when the longer the system is in operation. In this incident, i.e. after 100

hours, the inaccuracy was serious enough to cause the system to look in the wrong place for the incoming Scud (Blair et al., 1992).

As another illustration, consider a software that controls an airbag system of a car (Montoya, 2013). Failure to accommodate certain conditions in the software, such as while the owner of the car is in the middle of driving and attempting a drift, an unwanted self-deployment of the airbag (since the airbag sensors predicted a rollover is imminent) can prove fatal (Ireson, 2011).

All the aforementioned incidents have highlighted the importance of testing the software thoroughly especially in life threatening applications. As such, the next section will discuss the overview of how software testing is done.

1.1 Overview of Software Testing

Software testing relates to activities concerned with planning, preparation and evaluation of software products in order to determine that they satisfy specified requirements, to demonstrate that they are fit for purpose and to detect defects (ISQTB, 2012).

To carry out the aforementioned activities, software testing communities have provided a number of useful techniques that can be used to identify possible defects and anomalies. If most of the defects and anomalies are detected, the risk for software failure can indeed be minimized while establishing confidence that the software is working like it was intended to do (Zamli et al., 2009, Bentley, 2005, Harrold, 2000).

Figure 1.1 depicts a Deming Cycle that is often used for the control and continuous improvement of processes and products. The circle contains an iterative four-step management method termed PDCA (Plan–Do–Check–Act) (Moen and Norman, 2010).

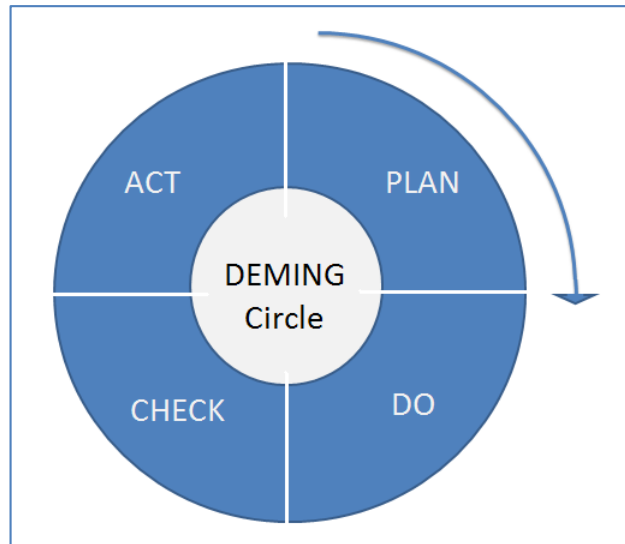


Figure 1.1 : A Deming Cycle (Moen and Norman, 2010)

The steps in each successive PDCA cycle are as follows:

- (a) Plan, where the objectives and processes necessary to deliver results in accordance with the expected output (the target or goals) are established,
- (b) Do, where the processes are executed according to the aforementioned plan,
- (c) Check, where the actual results are analyzed and compared against the expected output to ascertain any differences. Any deviation in implementation from the plan is studied for further actions, and
- (d) Act, where the corrective actions are requested to close the gap between the actual results versus the planned output. The differences are analyzed to determine their root causes.

Figure 1.2 depicts a Software Testing Cycle proposed by Zamli et al., (2009). The Software Testing Cycle has been designed based on the four steps adopted from the Deming Cycle. Here, as shown in Figure 1.2, the software testing activities can be categorized into three main stages.

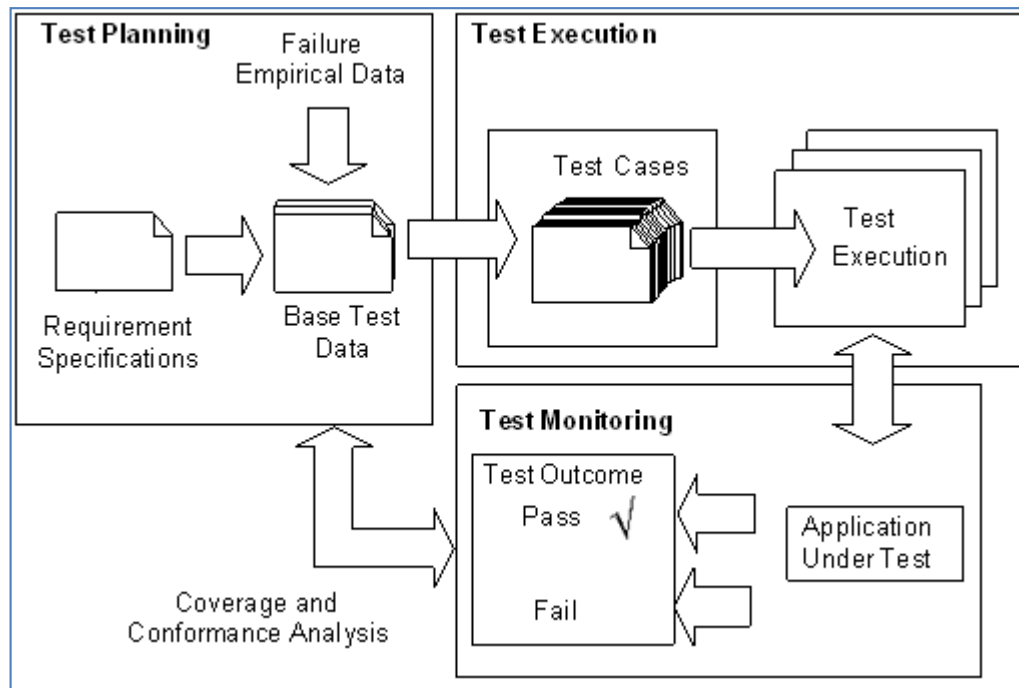


Figure 1.2 : Software Testing Cycle (Zamli et al., 2009)

By dissecting the activities into these stages, function of each stage can be described separately and thus the whole software testing activities can be comprehended clearly. Termed test cycle, these stages are Test Planning stage, Test Execution stage, and Test Monitoring stage (which consists of the check and act steps adopted from the Deming Cycle).

As the name suggests, Test Execution stage involves the activities to define and execute the planned test cases (and observing the results) with the intention to find bug/defect/error (e.g. a mistake in the specified requirement. Actually, the

bug/defect/error can also be found in every phases of software development process with different naming convention (terms), i.e. anomaly, crash, exception, failure, fault, incident or side effect). Usually, the procedure of running and executing the test cases are performed automatically using test scripts.

As depicted by Figure 1.2, software tester tests Application Under Test (AUT) using test cases. The test cases are generated from base test data using requirements specification and also include consideration on failure empirical data, which is based on known problems with similar systems (i.e. many products or systems, such as missiles and air bags, are considered one time/usage systems, hence the failure empirical data is a good candidate for test data in testing these systems). To test for a particular objective, such as to verify compliance with a specific requirement, software tester uses the requirements specification in order to determine what kind of input parameters and their values, execution pre-conditions, expected results and execution post conditions for the test cases (ISTQB, 2012).

Then, in the Test Monitoring stage, the results of the test execution will be checked whether they conform to the specification or not, as well as analyzing the test coverage (what gets tested, e.g. in Functional testing, a slice of functionality of the whole software is tested) against the stopping criteria to determine either the software testing process is done or not.

To ensure success, both aforementioned test cycle requires a good planning. As a result, we need to properly manage the testing by planning what we want to do before and after test execution. Therefore, the Test Planning stage involves the